


<b>Search Notes</b> 	<b>Application/Control No.</b> 10597536	<b>Applicant(s)/Patent Under Reexamination</b> MURKOWSKI ET AL.
	<b>Examiner</b> HIEN NGUYEN	<b>Art Unit</b> 3768

SEARCHED			
Class	Subclass	Date	Examiner
600	437	7/27/2009	HN

SEARCH NOTES		
Search Notes	Date	Examiner
East Search (inventor search, imag\$3, system\$1, ultraso\$3, display\$1, cart, imag\$3 same system\$1 same ultraso\$3 same display\$1 same cart, lock same release, plus search).	7/27/2009	HN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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